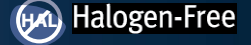


EPC2039 – Enhancement Mode Power Transistor

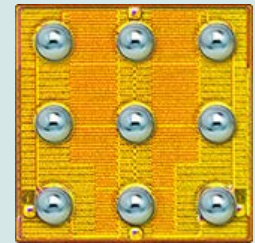
 V_{DS} , 80 V $R_{DS(on)}$, 25 mΩ I_D , 6.8 A

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Maximum Ratings			
PARAMETER		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage (Continuous)	80	V
	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	96	
I_D	Continuous ($T_A = 25^\circ\text{C}$, $R_{\theta JA} = 70^\circ\text{C/W}$)	6.8	A
	Pulsed (25°C , $T_{PULSE} = 300 \mu\text{s}$)	50	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	-40 to 150	$^\circ\text{C}$
T_{STG}	Storage Temperature	-40 to 150	

Thermal Characteristics			
PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3	$^\circ\text{C/W}$
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	28	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	81	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details



EPC2039 eGaN® FETs are supplied only in passivated die form with solder bumps
Die Size: 1.35 mm x 1.35 mm

Applications

- High Speed DC-DC conversion
- Wireless Power Transfer
- Lidar/Pulsed Power Applications

Benefits

- Ultra High Efficiency
- Ultra Low $R_{DS(on)}$
- Ultra Low Q_G
- Ultra Small Footprint

Static Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}$, $I_D = 300 \mu\text{A}$	80			V
I_{DSS}	Drain-Source Leakage	$V_{DS} = 64 \text{ V}$, $V_{GS} = 0 \text{ V}$		20	250	μA
I_{GSS}	Gate-to-Source Forward Leakage	$V_{GS} = 5 \text{ V}$		0.2	2	mA
	Gate-to-Source Reverse Leakage	$V_{GS} = -4 \text{ V}$		20	250	μA
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 2 \text{ mA}$	0.8	1.6	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS} = 5 \text{ V}$, $I_D = 6 \text{ A}$		20	25	mΩ
V_{SD}	Source-Drain Forward Voltage	$I_S = 0.5 \text{ A}$, $V_{GS} = 0 \text{ V}$		2.5		V

All measurements were done with substrate shorted to source.

Dynamic Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	Input Capacitance	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}$		210	260	pF
C_{RSS}	Reverse Transfer Capacitance			2		
C_{OSS}	Output Capacitance			115	175	
$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0\text{ to }40\text{ V}, V_{GS} = 0\text{ V}$		155		
$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			190		
R_G	Gate Resistance			0.5		Ω
Q_G	Total Gate Charge	$V_{DS} = 40\text{ V}, V_{GS} = 5\text{ V}, I_D = 6\text{ A}$		1910	2370	pC
Q_{GS}	Gate to Source Charge	$V_{DS} = 40\text{ V}, I_D = 6\text{ A}$		760		
Q_{GD}	Gate to Drain Charge			420		
$Q_{G(TH)}$	Gate Charge at Threshold			560		
Q_{OSS}	Output Charge	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}$		7640	11500	
Q_{RR}	Source-Drain Recovery Charge			0		

Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

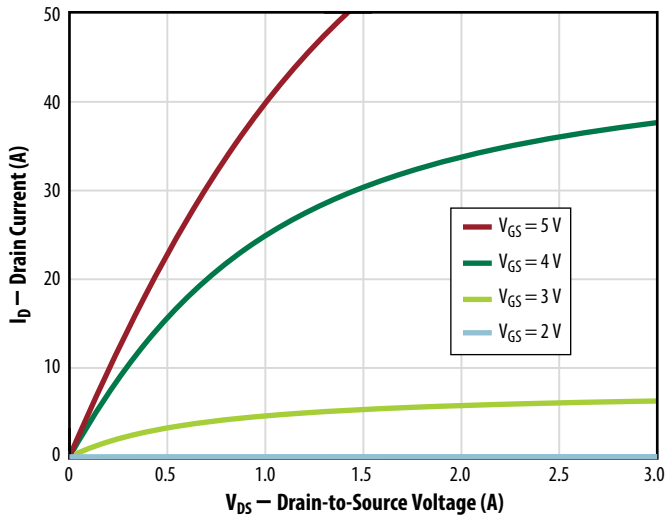
Figure 1: Typical Output Characteristics at 25°C 

Figure 2: Transfer Characteristics

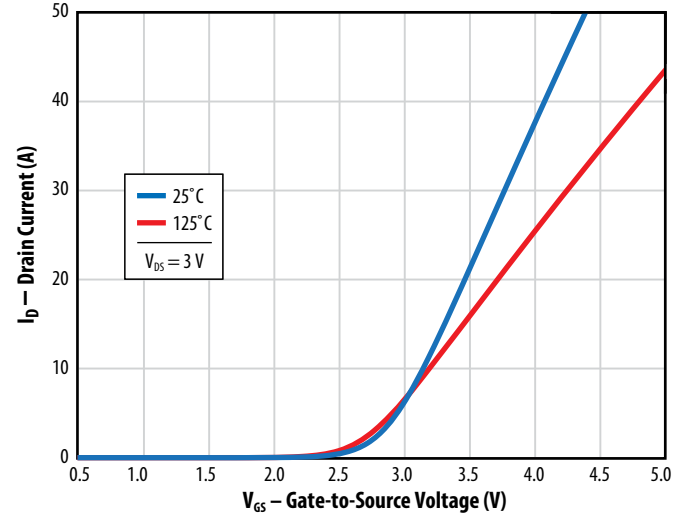
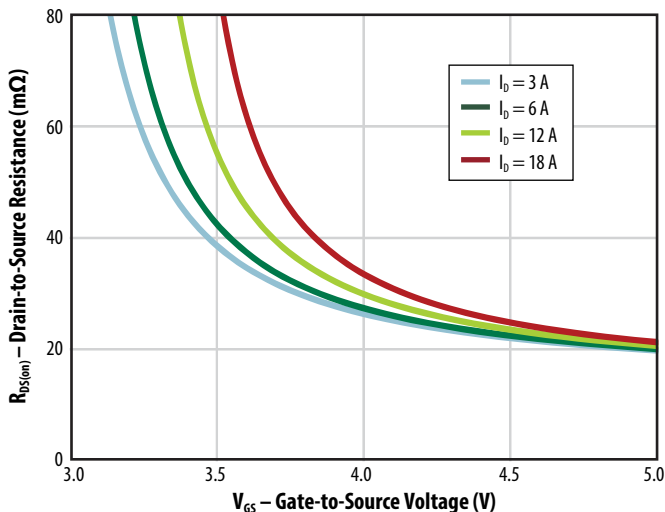
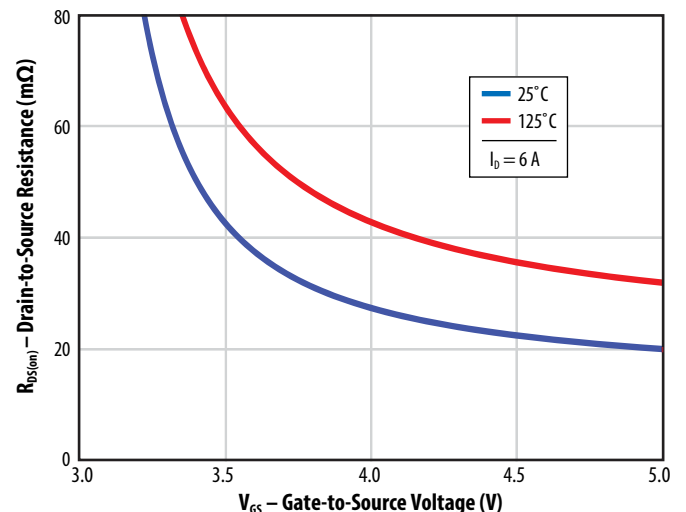
Figure 3: $R_{DS(on)}$ vs. V_{GS} for Various Drain CurrentsFigure 4: $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

Figure 5a: Capacitance (Linear Scale)

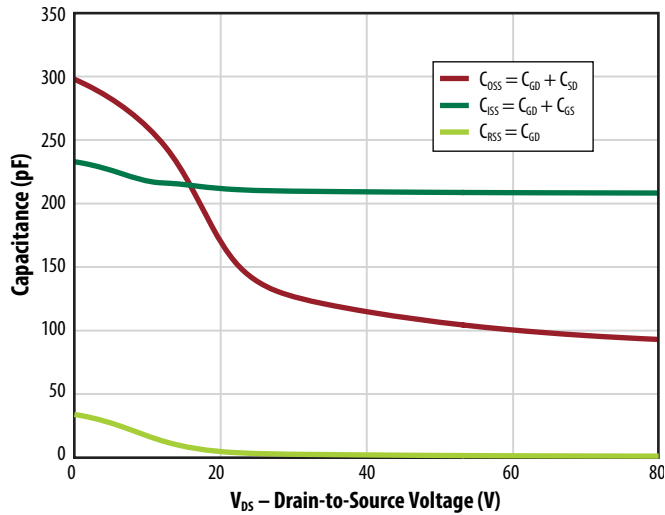


Figure 5b: Capacitance (Log Scale)

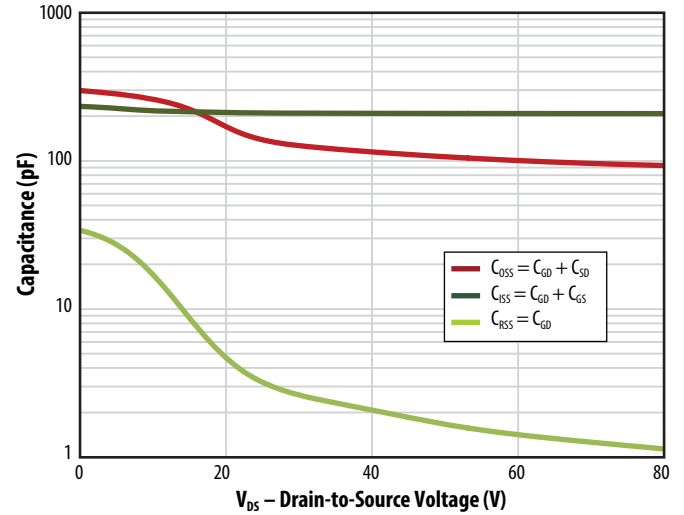


Figure 6: Gate Charge

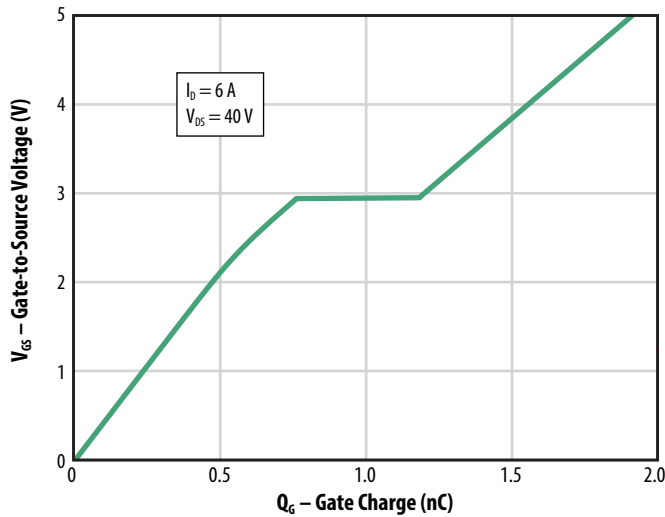


Figure 7: Reverse Drain-Source Characteristics

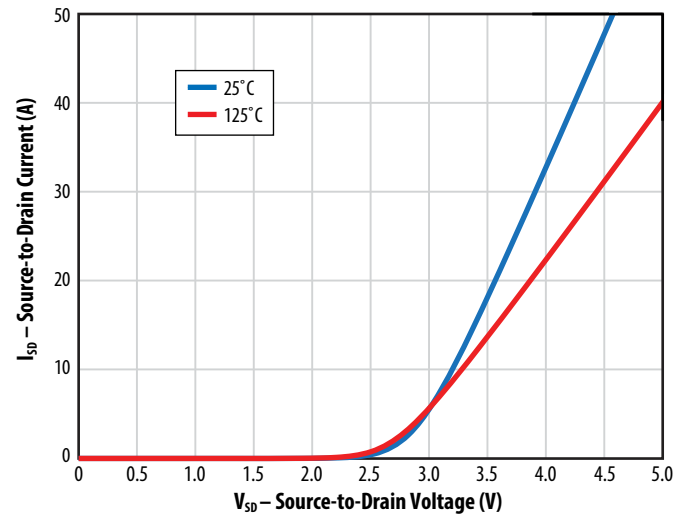


Figure 8: Normalized On-State Resistance vs. Temperature

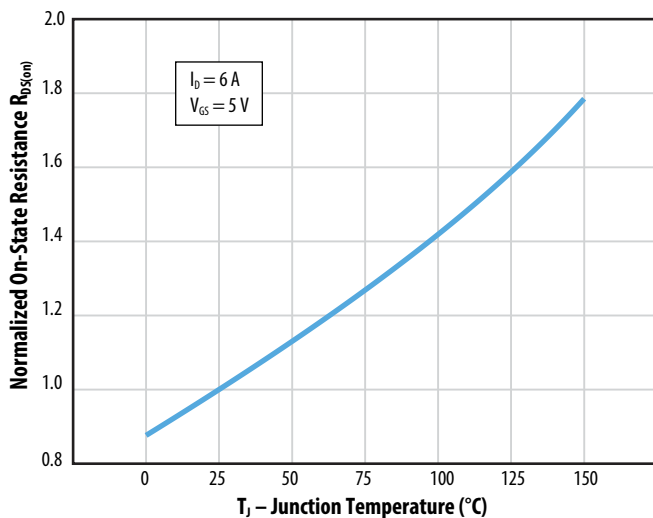
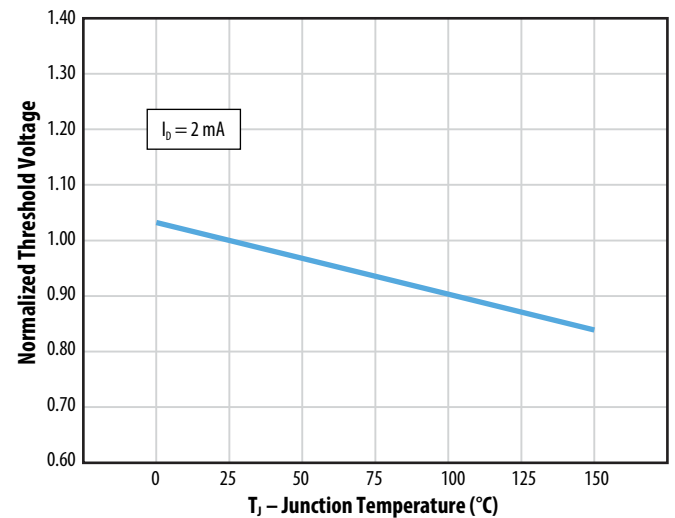


Figure 9: Normalized Threshold Voltage vs. Temperature



All measurements were done with substrate shorted to source.

Figure 10: Transient Thermal Response Curves

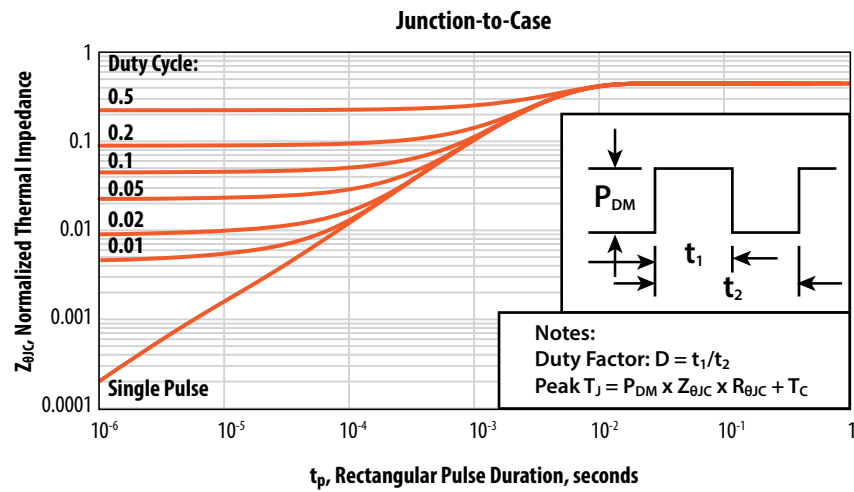
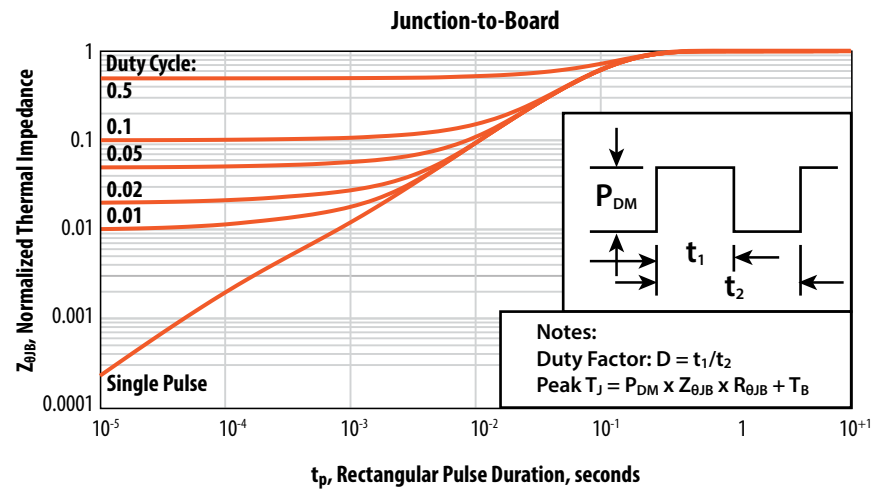
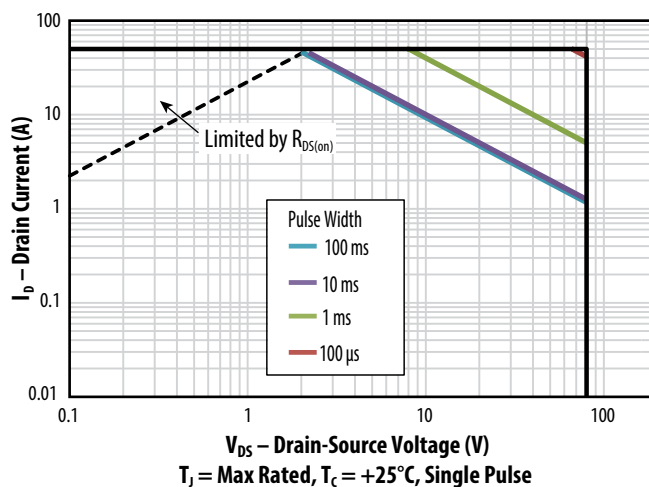
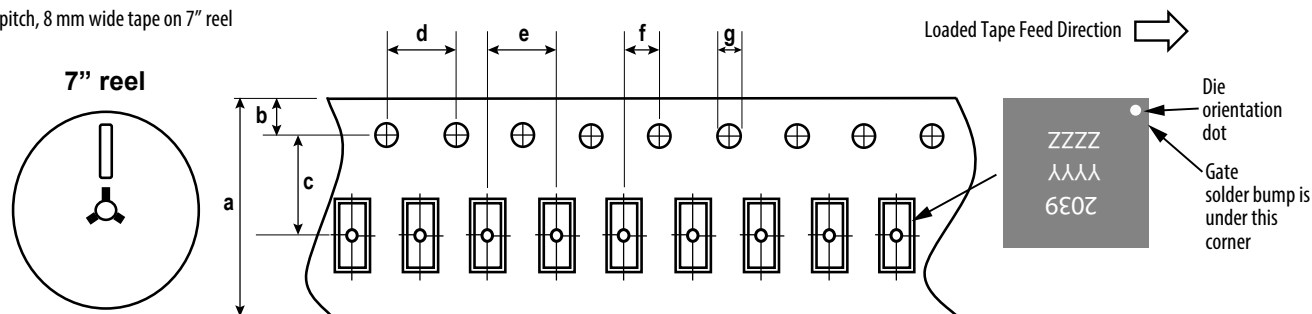


Figure 11: Safe Operating Area



TAPE AND REEL CONFIGURATION

4 mm pitch, 8 mm wide tape on 7" reel

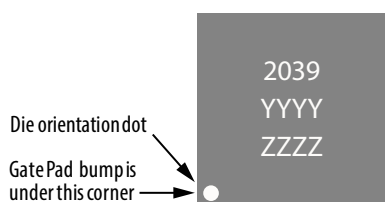


	EPC2039 (note 1)		
Dimension (mm)	target	min	max
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (note 2)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (note 2)	2.00	1.95	2.05
g	1.5	1.5	1.6

Die is placed into pocket
solder bump side down
(face side down)

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

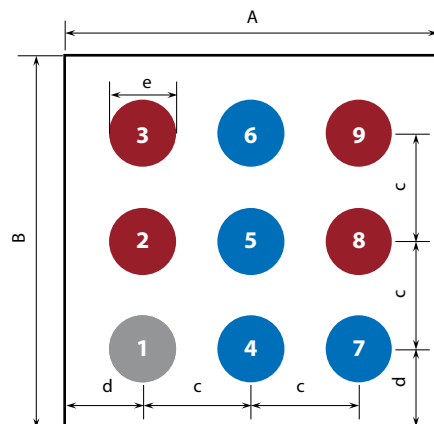
DIE MARKINGS



Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2039	2039	YYYY	ZZZZ

DIE OUTLINE

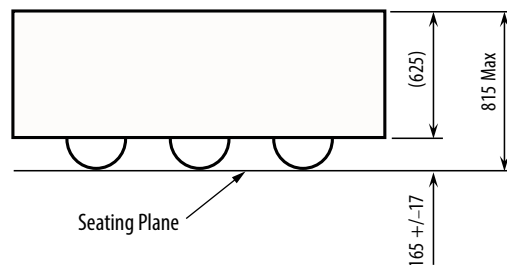
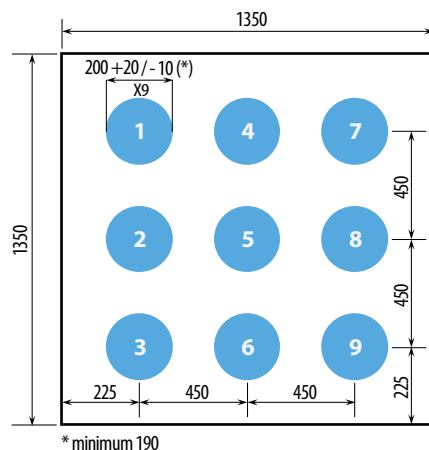
Solder Bump View



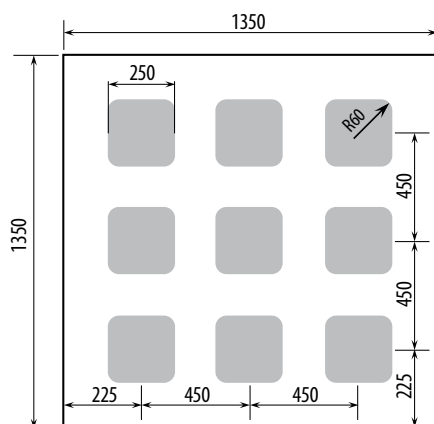
Pad 1 is Gate;
 Pads 4, 5, 6, 7 are Drain;
 Pads 2, 3, 8, 9 are Source

DIM	Micrometers		
	MIN	Nominal	MAX
A	1320	1350	1380
B	1320	1350	1380
c	450	450	450
d	210	225	240
e	187	208	229

Side View

**RECOMMENDED LAND PATTERN**(measurements in μm)

The land pattern is solder mask defined
 Solder mask is 10 μm smaller per side than bump

RECOMMENDED STENCIL DRAWING(measurements in μm)

Recommended stencil should be 4 mil (100 μm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at
<https://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx>

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 change without notice.

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